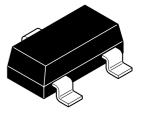


# ZXTN25040DFL 40V, SOT23, NPN low power transistor

### Summary

 $BV_{CEX} > 130V$   $BV_{CEO} > 40V$   $BV_{ECO} > 6V$   $I_{C(cont)} = 1.5A$   $V_{CE(sat)} < 85mV @ 1A$   $R_{CE(sat)} = 59m\Omega$  $P_{D} = 350mW$ 



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Е

В

Complementary part number ZXTP25040DFL

## Description

Advanced process capability has been used to achieve high current gain hold up making this device ideal for applications requiring high pulse currents.

### Features

- High peak current
- Low saturation voltage
- 130V forward blocking voltage
- 6V reverse blocking voltage

## Applications

- MOSFET and IGBT gate driving
- DC-DC conversion
- LED driving
- Interface between low voltage IC's and loads

## Ordering information



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Device	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXTN25040DFLTA	7	8	3000

## **Device marking**

1B7

## Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Collector-base voltage	V <sub>CBO</sub>	130	V
Collector-emitter voltage (forward blocking)	V <sub>CEX</sub>	130	V
Collector-emitter voltage	V <sub>CEO</sub>	40	V
Emitter-collector voltage (reverse blocking)	V <sub>ECO</sub>	6	V
Emitter-base voltage	V <sub>EBO</sub>	7	V
Continuous collector current <sup>(a)</sup>	Ι <sub>C</sub>	1.5	А
Base current	Ι <sub>Β</sub>	0.5	А
Peak pulse current	I <sub>СМ</sub>	6	А
Power dissipation at $T_{amb} = 25^{\circ}C^{(a)}$	P <sub>D</sub>	350	mW
Linear derating factor		2.8	mW/°C
Operating and storage temperature range	T <sub>j</sub> , T <sub>stg</sub>	-55 to 150	°C

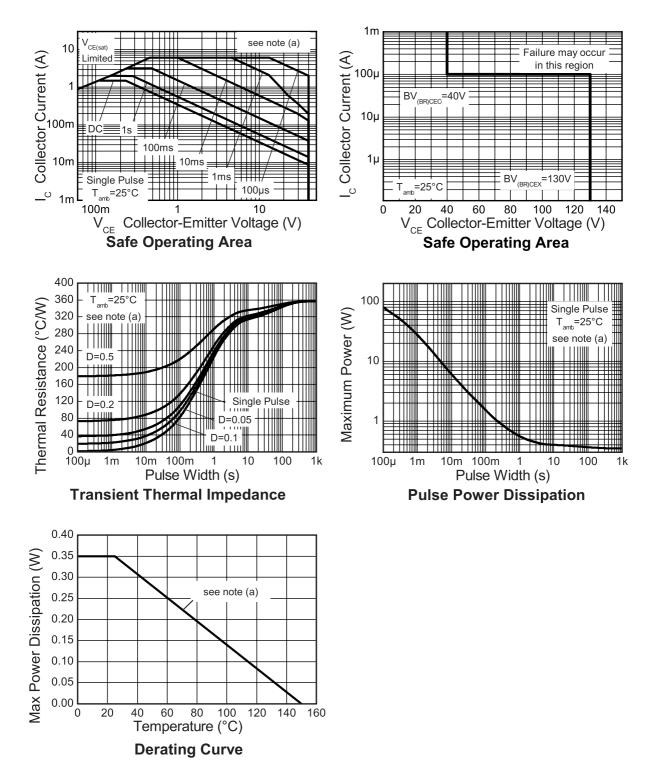
## **Thermal resistance**

Parameter	Symbol	Limit	Unit
Junction to ambient <sup>(a)</sup>	$R_{\ThetaJA}$	357	°C/W

### NOTES:

(a) For a device surface mounted on 25mm x 25mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

## **Characteristics**



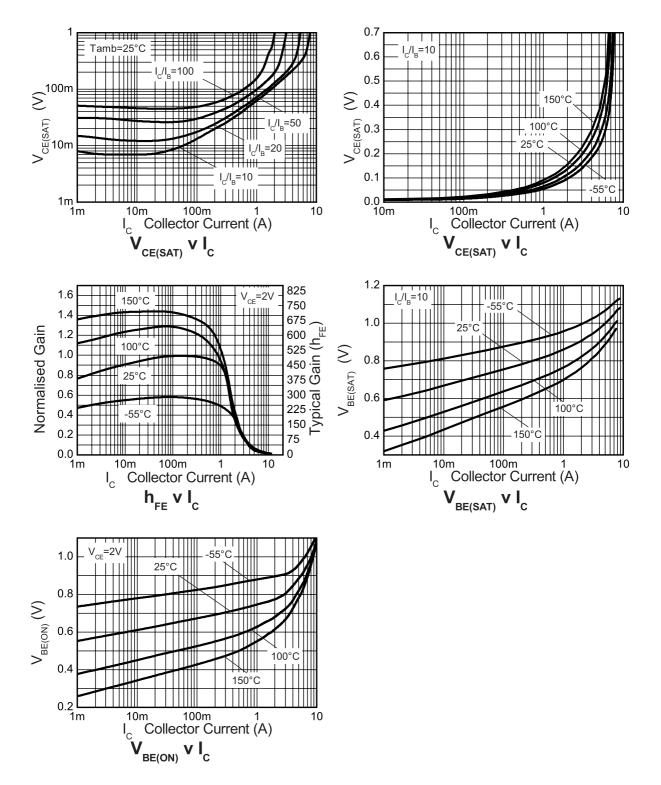
<b>Electrical characteristics</b>	(at ]	T <sub>amb</sub>	= 25°	°C unles	s ot	herwis	se stated)	

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Collector-base breakdown voltage	BV <sub>CBO</sub>	130	170		V	I <sub>C</sub> = 100μA
Collector-emitter breakdown voltage (forward blocking)	BV <sub>CEX</sub>	130	170		V	$I_{C}$ = 100μA; $R_{BE}$ < 1k $\Omega$ or -1V < V <sub>BE</sub> < 0.25V
Collector-emitter breakdown voltage (base open)	BV <sub>CEO</sub>	40	63		V	I <sub>C</sub> = 10mA <sup>(*)</sup>
Emitter-base breakdown voltage	BV <sub>EBO</sub>	7	8.3		V	I <sub>E</sub> = 100μA
Emitter-collector breakdown voltage (reverse blocking)	BV <sub>ECX</sub>	6	7.4		V	$I_E$ = 100μA, $R_{BC}$ < 1kΩ or 0.25V > V <sub>BC</sub> > -0.25V
Emitter-collector breakdown voltage (base open)	BV <sub>ECO</sub>	6	7.4		V	I <sub>E</sub> = 100μA,
Collector cut-off current	I <sub>CBO</sub>		<1	50 20	nA μA	V <sub>CB</sub> = 100V V <sub>CB</sub> = 100V, T <sub>amb</sub> = 100°C
Collector emitter cut-off current	I <sub>CEX</sub>		<1	100	nA	$V_{CE}$ = 100V; $R_{BE}$ < 1k $\Omega$ or -1V < $V_{BE}$ < 0.25V
Emitter cut-off current	I <sub>EBO</sub>		<1	50	nA	V <sub>EB</sub> = 5.6V
Collector-emitter saturation	V <sub>CE(sat)</sub>		35	50	mV	I <sub>C</sub> = 0.5A, I <sub>B</sub> = 50mA <sup>(*)</sup>
voltage			60	80	mV	I <sub>C</sub> = 0.5A, I <sub>B</sub> = 10mA <sup>(*)</sup>
			70	85	mV	I <sub>C</sub> = 1A, I <sub>B</sub> = 100mA
			145	185	mV	I <sub>C</sub> = 1.5A, I <sub>B</sub> = 30mA <sup>(*)</sup>
			235	285	mV	I <sub>C</sub> = 4A, I <sub>B</sub> = 400mA <sup>(*)</sup>
Base-emitter saturation voltage	V <sub>BE(sat)</sub>		840	950	mV	l <sub>C</sub> = 1.5A, l <sub>B</sub> = 30mA <sup>(*)</sup>
Base-emitter turn-on voltage	V <sub>BE(on)</sub>		770	850	mV	$I_{C} = 1.5A, V_{CE} = 2V^{(*)}$
Static forward current	h <sub>FE</sub>	300	450	900		$I_{C} = 10 \text{mA}, V_{CE} = 2V^{(*)}$
transfer ratio		300	400			$I_{C} = 1A, V_{CE} = 2V^{(*)}$
		170	250			$I_{C} = 1.5A, V_{CE} = 2V^{(*)}$
		25	40			$I_{C} = 4A, V_{CE} = 2V^{(*)}$
Transition frequency	f <sub>T</sub>		190		MHz	I <sub>C</sub> = 50mA, V <sub>CE</sub> = 10V f = 100MHz
Output capacitance	C <sub>obo</sub>		11.7	20	pF	V <sub>CB</sub> = 10V, f = 1MHz <sup>(*)</sup>
Delay time	t <sub>(d)</sub>		64		ns	V <sub>CC</sub> = 10V,
Rise time	t <sub>(r)</sub>		108		ns	I <sub>C</sub> = 1A,
Storage time	t <sub>(s)</sub>		428		ns	I <sub>B1</sub> = I <sub>B2</sub> = 10mA.
Fall time	t <sub>(f)</sub>		130		ns	

### NOTES:

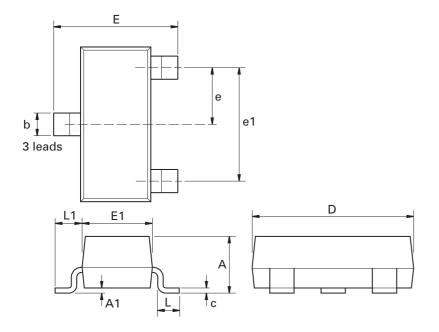
(\*) Measured under pulsed conditions. Pulse width  $\leq$ 300µs; duty cycle  $\leq$ 2%.

## **Typical characteristics**



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## Package outline - SOT23



Dim.	Millim	neters	Inches		Dim.	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Max.	Max.
А	2.67	3.05	0.105	0.120	Н	0.33	0.51	0.013	0.020
В	1.20	1.40	0.047	0.055	K	0.01	0.10	0.0004	0.004
С	-	1.10	-	0.043	L	2.10	2.50	0.083	0.0985
D	0.37	0.53	0.015	0.021	М	0.45	0.64	0.018	0.025
F	0.085	0.15	0.0034	0.0059	N	0.95 N	MOM	0.0375	NOM
G	1.90	NOM	0.075	NOM	-	-	-	-	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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